## Search Notes



Application/Control N	c
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Reexamination
8060 SAHASHI ET AL.

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Art Unit

Applicant(s)/Patent Under

Examiner WEI ZHAO

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## SEARCHED

Class	Subclass	Date	Examiner		
370	389	7/8	WZ		
709	244, 227	7/8	WZ		

## **SEARCH NOTES**

Search Notes	Date	Examiner
Did double patenting search and searched using US-PGPUB, USPAT, DERWENT, IBM_TDB in EAST	7/8	WZ
Did inventorship search for ODP in Palm Resource Center	7/8	WZ

## INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
370	389	7/8	WZ

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